

**Notice of References Cited**

Application/Control No.

10/568,346

Applicant(s)/Patent Under  
Reexamination  
IKAWA ET AL.

Examiner

YOSIEF BERNHANE

Art Unit

2419

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,834,326	12-2004	Wang et al.	711/114
*	C	US-6,496,502	12-2002	Fite et al.	370/389
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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